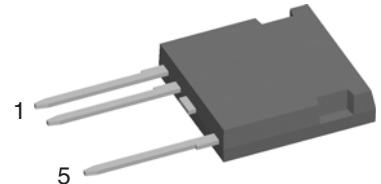
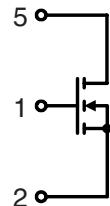


HiPerFET™
Power MOSFET
 in High Voltage ISOPLUS i4-PAC™

I_{D25} = 22 A
V_{DSS} = 1000 V
R_{DSon} = 390 mΩ



MOSFET

Symbol	Conditions	Maximum Ratings		
V _{DSS}	T _{VJ} = 25°C to 150°C	1000	V	
V _{GS}		±20	V	
I _{D25}	T _C = 25°C	22	A	
I _{D90}	T _C = 90°C	15	A	
I _{F25}	(diode) T _C = 25°C	120	A	
I _{F90}	(diode) T _C = 90°C	75	A	
dv/dt	V _{DS} < V _{DSS} ; I _F ≤ 100A; di _F /dt ≤ 100A/μs; R _G = 2 Ω T _{VJ} = 150°C	5	V/ns	
E _{AR}	T _C = 25°C	64	mJ	

Symbol	Conditions	Characteristic Values		
		(T _{VJ} = 25°C, unless otherwise specified)	min.	typ.
R _{DSon}	V _{GS} = 10 V; I _D = I _{D90}		390	mΩ
V _{GSth}	V _{DS} = 20 V; I _D = 8 mA;	2.5	5	V
I _{DSS}	V _{DS} = V _{DSS} ; V _{GS} = 0 V; T _{VJ} = 25°C T _{VJ} = 125°C	0.25	0.1	mA
I _{GSS}	V _{GS} = ±20 V; V _{DS} = 0 V		200	nA
Q _g Q _{gs} Q _{gd}	{ V _{GS} = 10 V; V _{DS} = 500 V; I _D = 12 A	250 55 135		nC nC nC
t _{d(on)} t _r t _{d(off)} t _f	{ V _{GS} = 10 V; V _{DS} = 500 V; I _D = 12 A; R _G = 1 Ω	35 35 75 21		ns ns ns ns
V _F	(diode) I _F = 12 A; V _{GS} = 0 V		1.5	V
t _{rr}	(diode) I _F = 24 A; -di/dt = 100 A/μs; V _{DS} = 100 V	250		ns
R _{thJC}			0.32	K/W

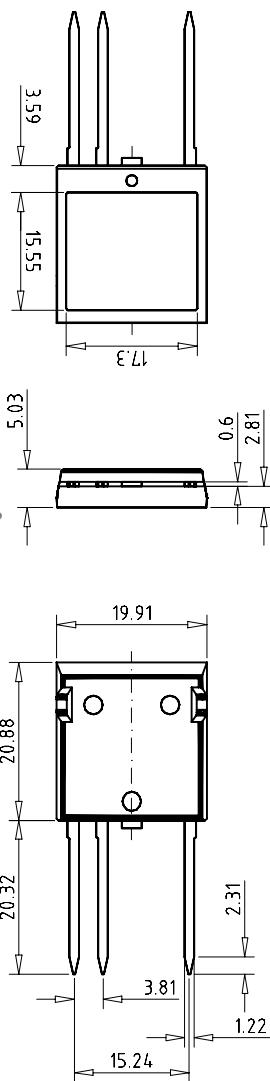
IXYS reserves the right to change limits, test conditions, and dimensions.

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Component

Symbol	Conditions	Maximum Ratings
T_{VJ}		-55...+150 °C
T_{stg}		-55...+125 °C
V_{ISOL}	$I_{ISOL} \leq 1 \text{ mA}; 50/60 \text{ Hz}$	2500 V~
F_c	mounting force with clip	20...120 N

Symbol	Conditions	Characteristic Values		
		min.	typ.	max.
d_s, d_A	D pin - S pin	7.0		mm
d_s, d_A	pin - backside metal	5.5		mm
R_{thCH}	with heatsink compound	0.15		K/W
Weight		9		g

Dimensions in mm (1 mm = 0.0394")

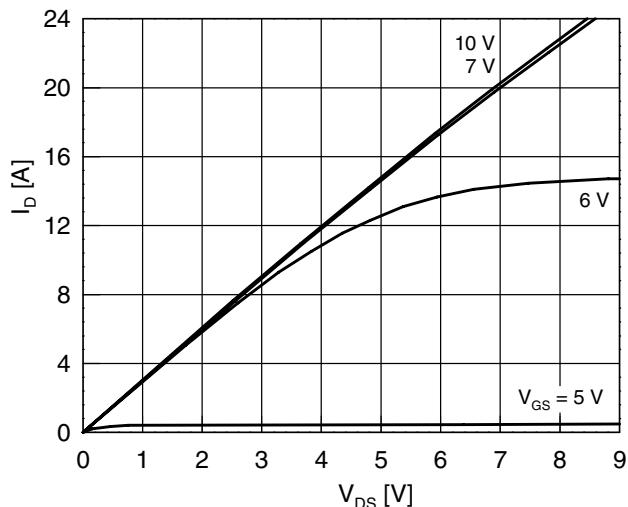


Fig. 1. Output Characteristics @ 25°C

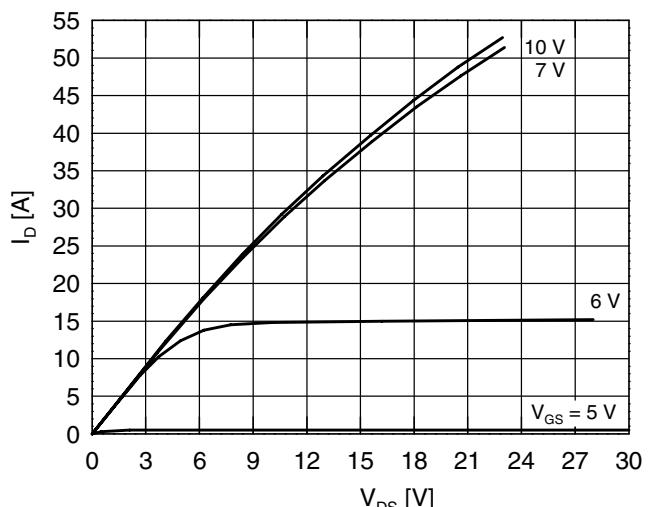


Fig. 2. Extended Output Characteristics @ 25°C

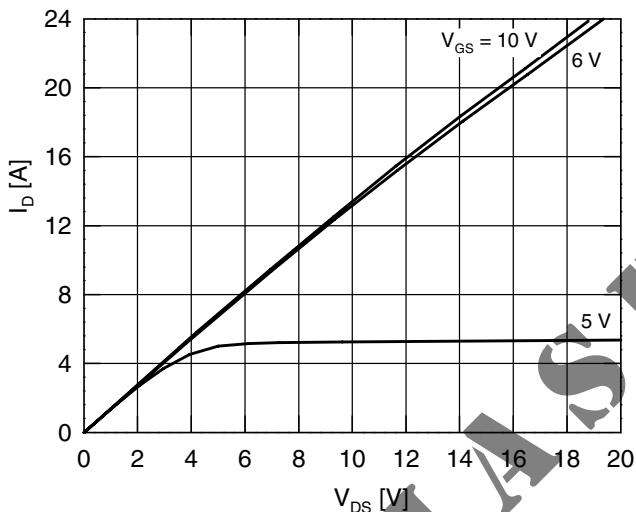


Fig. 3. Output Characteristics @ 125°C

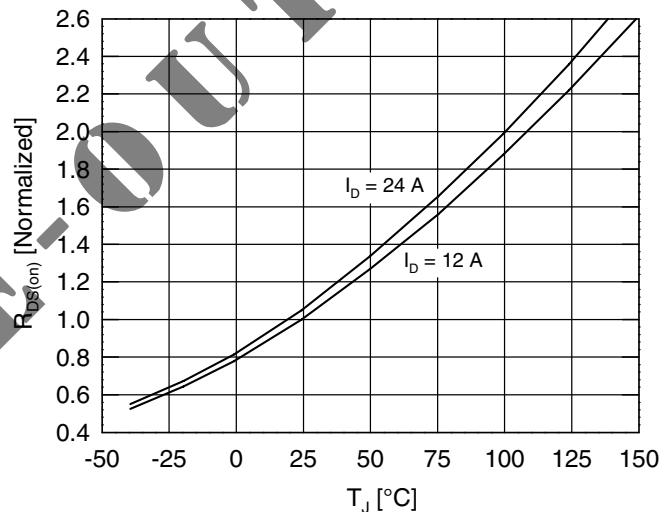
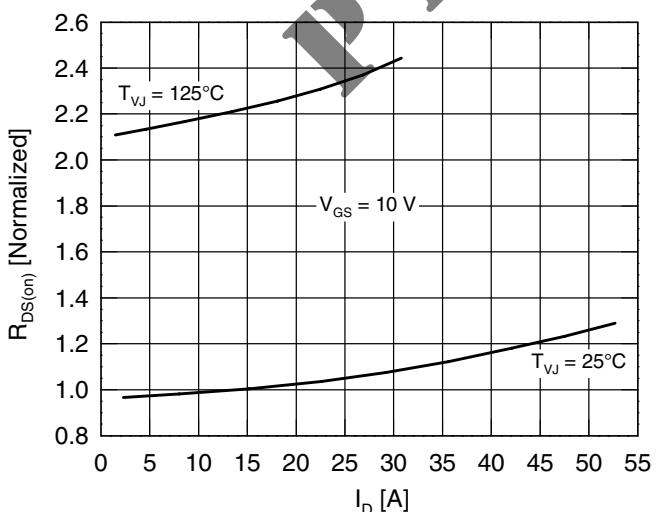
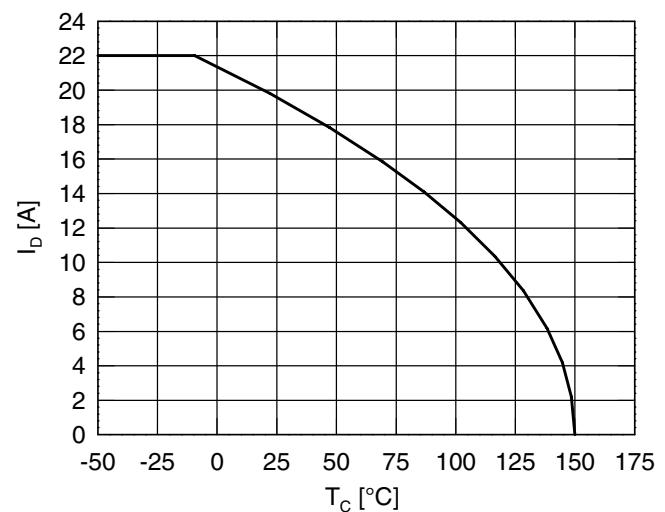
Fig. 4. $R_{DS(on)}$ Normalized to $I_D = 12\text{ A}$ Value versus Junction TemperatureFig. 5. $R_{DS(on)}$ Normalized to $I_D = 12\text{ A}$ Value versus Drain Current

Fig. 6. Max. Drain Current vs. Case Temperature

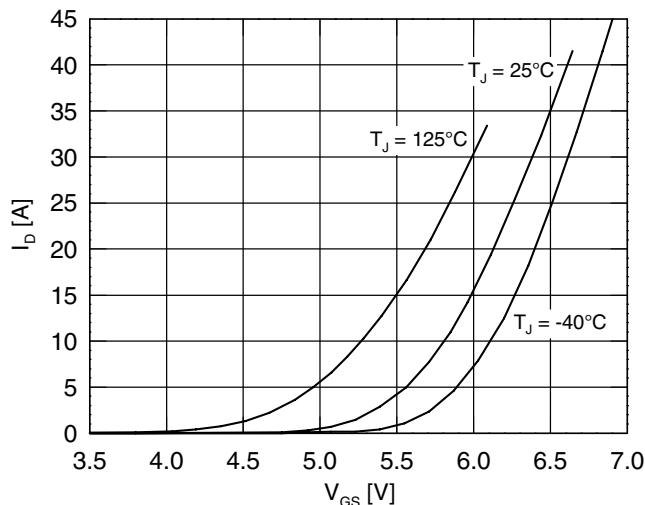


Fig. 7. Input Admittance

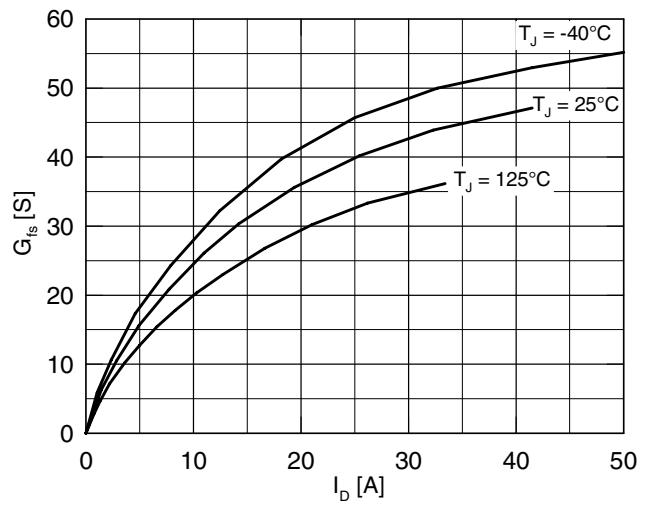


Fig. 8. Transconductance

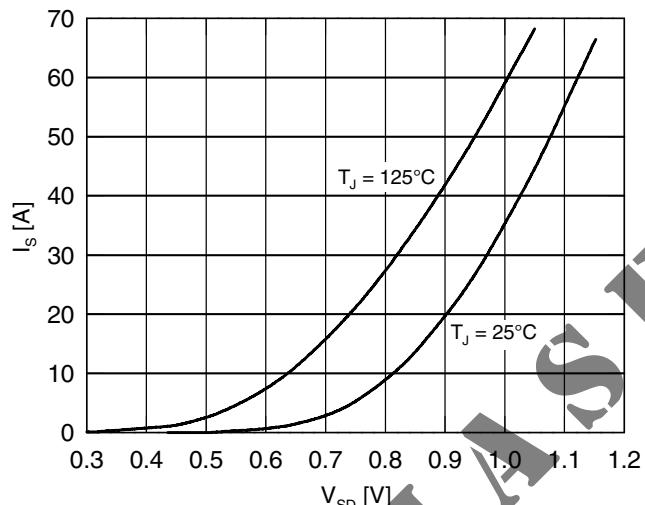


Fig. 9. Forward Voltage Drop of Intrinsic Diode

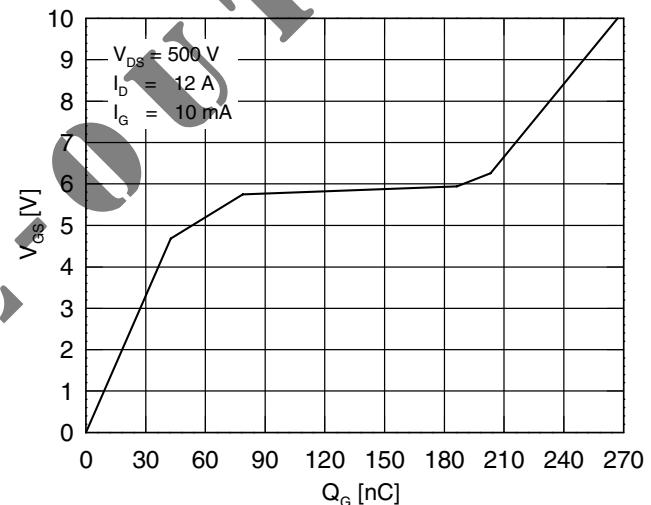


Fig. 10. Gate Charge

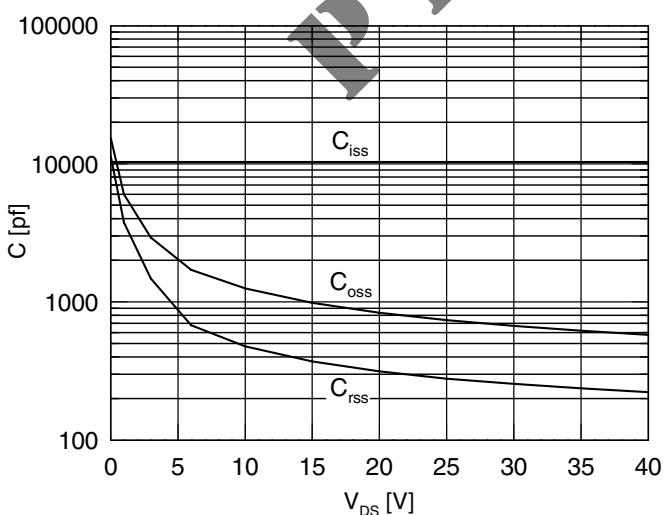


Fig. 11. Capacitance

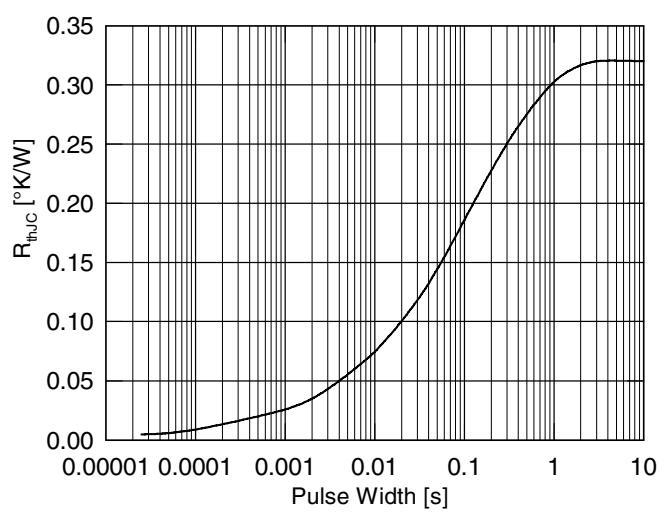


Fig. 12. Max. Transient Thermal Resistance